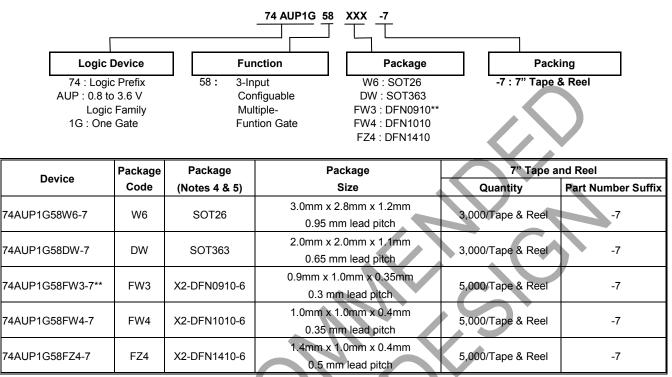


Ordering Information



Notes: 4. Pad layout as shown on Diodes Inc. suggested pad layout document AP02001, which can be found on our website at

http://www.diodes.com/datasheets/ap02001.pdf.
 The taping orientation is located on our website at http://www.diodes.com/datasheets/ap02007.pdf.

** The X2-DFN0910-6 is a future product.

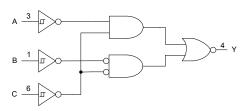
Pin Descriptions

Pin Name	Function	$\langle \langle \rangle$
В	Data Input	
GND	Ground	
A	Data Input	
Y	Data Output	
Vcc	Supply Voltage	
С	Data Input	

Function Table

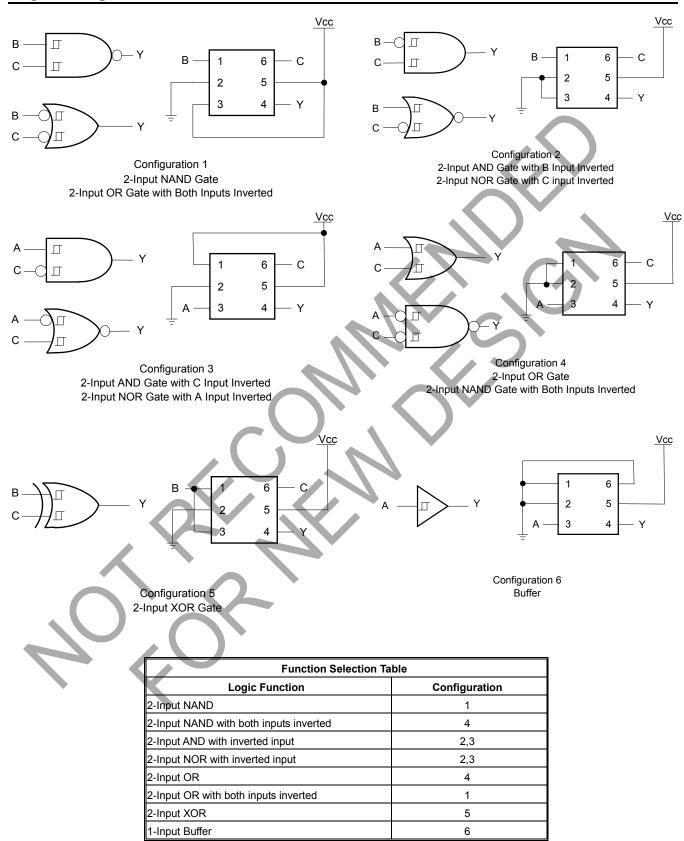
	Inputs		Output
С	В	Α	Y
L	L	L	L
L	L	Н	Н
L	Н	L	L
L	Н	Н	Н
Н	L	L	Н
Н	L	Н	Н
Н	Н	L	L
Н	Н	Н	L

Logic Diagram





Logic Configurations





Absolute Maximum Ratings (Notes 6 & 7)

Symbol	Description	Rating	Unit
ESD HBM	Human Body Model ESD Protection	2	kV
ESD CDM	Charged Device Model ESD Protection	1	kV
ESD MM	Machine Model ESD Protection	200	V
V _{CC}	Supply Voltage Range	-0.5 to +4.6	V
VI	Input Voltage Range	-0.5 to +4.6	V
Vo	Voltage applied to output in high or low state	-0.5 to V _{CC} +0.5	V
lık	Input Clamp Current VI<0	-50	mA
Ι _{ΟΚ}	Output Clamp Current (V _O < 0)	-50	mA
lo	Continuous Output Current ($V_O = 0$ to V_{CC})	±20	mA
lcc	Continuous Current through V _{CC}	50	mA
Ignd	Continuous Current through GND	-50	mA
TJ	Operating Junction Temperature	-40 to +150	°C
T _{STG}	Storage Temperature	-65 to +150	°C

Notes:

6. Stresses beyond the absolute maximum may result in immediate failure or reduced reliability. These are stress values and device operation should be within recommend values.7. Forcing the maximum allowed voltage could cause a condition exceeding the maximum current or conversely forcing the maximum current could cause a condition exceeding the maximum voltage. The ratings of both current and voltage must be maintained within the controlled range.

Recommended Operating Conditions (Note 8)

Symbol		Parameter	Min	Мах	Unit
V _{CC}	Operating Voltage		0.8	3.6	V
VI	Input Voltage		0	3.6	V
M.	Output Voltage	Active Mode	0	V _{CC}	V
Vo	Culput Voltage	Power Down Mode	0	3.6	V
		V _{CC} = 0.8 V	-	-20	μA
		V _{CC} = 1.1 V	-	-1.1	
		V _{CC} = 1.4 V	-	-1.7	
Іон	High-level output current	V _{CC} = 1.65 V	-	-1.9	mA
		V _{CC} = 2.3 V	-	-3.1	
		$V_{\rm CC} = 3.0 \rm V$	-	-4	
	\sim	V _{CC} = 0.8 V	-	20	μA
(V _{CC} = 1.1 V	-	1.1	
	Low busic output oursent	V _{CC} = 1.4 V	-	1.7	
IOL	Low-level output current	V _{CC} = 1.65 V	-	1.9	mA
		V _{CC} = 2.3 V	-	3.1	
		V _{CC} = 3.0 V	-	4	
TA	Operating free-air temperature	-	-40	+125	°C

Note: 8. Unused inputs should be held at Vcc or Ground.



Electrical Characteristics

0 milest	Demonstern	To at O an dition o	N	T _A = -	+25°C	T _A =-40	to +85°C	11
Symbol	Parameter	Test Conditions	Vcc	Min	Мах	Min	Мах	Unit
		-	0.8V	0.3	0.65	0.3	0.7	
	Desitive Coing	-	1.1V	0.53	0.9	0.53	0.9	
V _{T+}	Positive-Going Input Threshold	-	1.4V	0.74	1.11	0.74	1.11	v
V _{T+}	•	-	1.65V	0.91	1.29	0.91	1.29	v
	Voltage	-	2.3V	1.37	1.77	1.37	1.77	
		-	3.0V	1.88	2.29	1.88	2.29	
		-	0.8V	0.1	0.6	0.1	0.6	
	Negative-Going	-	1.1V	0.26	0.65	0.26	0.65	
V _{T-}	Input Threshold	-	1.4V	0.39	0.75	0.39	0.75	v
• 1-	Voltage	-	1.65V	0.47	0.84	0.47	0.84	-
	Voltage	-	2.3V	0.69	1.04	0.69	1.04	
		-	3.0V	0.88	1.24	0.88	1.24	
		-	0.8V	0.07	0.5	0.07	0.5	
		-	1.1V	0.08	0.46	0.08	0.46	
ΔV_T	Hysteresis	-	1.4V	0.18	0.56	0.18	0.56	V
	(V _{T+} - V _{T-)}	-	1.65V	0.27	0.66	0.27	0.66	
		-	2.3V	0.53	0.92	0.53	0.92	
		-	3.0V	0.79	1.31	0.79	1.31	
		I _{OH} = -20μA	0.8V to 3.6V	V _{cc} – 0.1	-	V _{cc} – 0.1	-	
		I _{он} = -1.1mA	1.1V	0.75 x V _{cc}		0.7 x V _{CC}	-	
		I _{он} = -1.7mA	1.4V	1.11	-	1.03	-	
V _{OH}	High-Level	I _{он} = -1.9mA	1.65V	1.32	-	1.3	-	v
♥ OH	Output Voltage	I _{OH} = -2.3mA	2.3V	2.05		1.97	-	, v
		I _{он} = -3.1mA	2.00	1.9	-	1.85	-	
		I _{он} = -2.7mA	2)/	2.72		2.67	-	
		I _{OH} = -4mA	3V	2.6	-	2.55	-	
		I _{OL} = 20μΑ	0.8V to 3.6V		0.1	-	0.1	
		I _{OL} = 1.1mA	1.1V		0.3 x V _{CC}	-	0.3 x V _{CC}	
		I _{oL} = 1.7mA	1.4V	-	0.31	-	0.37	
	Low-Level Input	$I_{OL} = 1.9 \text{mA}$	1.65 V	-	0.31	-	0.35	
V _{OL}	Voltage	$I_{OL} = 2.3$ mA		-	0.31	-	0.33	V
		$I_{OL} = 3.1 \text{mA}$	2.3V	-	0.44	-	0.45	
					0.44	_	0.43	
		I _{OL} = 2.7mA I _{OL} = 4 mA	3V	-				
				-	0.44	-	0.45	
I _I	Input Current	A or B Input V ₁ =GND to 3.6 V	0V to 3.6V	-	± 0.1	-	± 0.5	μA
I _{OFF}	Power Down Leakage Current	V ₁ or V ₀ = 0V to 3.6V	0	-	± 0.2	-	± 0.6	μA
ΔI_{OFF}	Delta Power Down Leakage Current	$V_1 \text{ or } V_0 =$ OV to 3.6V	0V to 0.2 V	-	± 0.2	-	± 0.6	μA
Icc	Supply Current	$V_1 = GND \text{ or } V_{CC}$ $I_0 = 0$	0.8V to 3.6V	-	0.5	-	0.9	μA
ΔI_{CC}	Additional Supply Current	One input at V_{CC} – 0.6 V Other inputs at V_{CC} or GND	3.3V	-	40	-	50	μA



Electrical Characteristics (continued)

Or mark and	Demonstration	Tool Constitution	Nee	T _A =-40 to	o +125°C	11 14
Symbol	Parameter	Test Conditions	Vcc	Min	Мах	Unit
		-	0.8V	0.3	0.7	
	Positive-Going	-	1.1V	0.53	0.92	
V	Input	-	1.4V	0.74	1.13	v
V_{T+}	Threshold	-	1.65V	0.91	1.31	v
	Voltage	-	2.3V	1.37	1.8	
		-	3.0V	1.88	2.32	
		-	0.8V	0.1	0.6	
	Negative-	-	1.1V	0.26	0.65	
V _{T-}	Going Input	-	1.4V	0.39	0.75	V
• -	Threshold	-	1.65V	0.47	0.84	
	Voltage	-	2.3V	0.69	1.04	
		-	3.0V	0.88	1.24	
		-	0.8V	0.07	0.5	
	Lluotorogia	-	1.1V	0.08	0.46	
ΔV_{T}	Hysteresis	-	1.4V	0.18	0.56	V
	(V _{T+} - V _{T-)}	-	1.65V	0.27	0.66	
		-	2.3V 3.0V	0.53 0.79	0.92	
		I _{он} = -20µА	0.8V to 3.6V	V _{cc} - 0.11	-	
			1.1V	0.6 x V _{cc}	-	
		$I_{OH} = -1.1 \text{mA}$		0.0 x V _{CC}		
	High-Level	$I_{OH} = -1.7 \text{mA}$	1.4V		·	
V _{OH}	Output	I _{OH} = -1.9mA	1.65V	1.17	-	V
	Voltage	I _{OH} = -2.3mA	2.3V	1.77		-
		I _{он} = -3.1mA		1.67	-	
		I _{OH} = -2.7mA	3V	2.40	-	
		I _{он} = -4mA		2.30	-	
		I _{OL} = 20μΑ	0.8V to 3.6V	-	0.11	
		I _{OL} = 1.1mA	1.1V	-	$0.33 \text{ x } V_{CC}$	
		I _{OL} = 1.7mA	1.4V	-	0.41	
V	Low-Level	1 _{0L} = 1.9mA	1.65 V	-	0.39	v
V _{OL}	Input Voltage	I _{OL} = 2.3mA	0.014	-	0.36	v
		I _{OL} = 3.1mA	2.3∨	-	0.50	1
		I _{OL} = 2.7mA		-	0.36	1
		$I_{OL} = 4mA$	3V	-	0.50	1
		A or B Input		-		
lı 🚺	Input Current	V_1 = GND to 3.6 V	0V to 3.6V		± 0.75	μA
	Power Down			-		
IOFF	Leakage	V_1 or $V_0 =$ 0V to 3.6V	0		± 1.0	μA
	Current	00.00				
	Delta Power Down					
ΔI _{OFF}	Leakage	V ₁ or V ₀ = 0V to 3.6V	0V to 0.2 V	-	± 2.5	μA
	Current	0 4 10 3.0 4				
	Supply	$V_I = GND \text{ or } V_{CC}$	0.9 (to 2.6)		1 4	
Icc	Current	I ₀ =0	0.8V to 3.6V	-	1.4	μA
	Additional	One input at V _{CC} –				
ΔI_{CC}	Supply	0.6 V Other inputs	3.3V	-	75	μA
	Current	at V _{cc} or GND				



Package Characteristics

Symbol	Parameter	Package	Test Conditions	Min	Тур.	Мах	Unit
		SOT26		-	166	-	
		SOT363		-	371	-	
θյΑ	θ _{JA} Thermal Resistance Junction	X2-DFN0910-6	(Note 9)	-	450	-	°C/M
to-Ambient	to-Ambient	X2-DFN1010-6		-	445	-	
		X2-DFN1410-6		-	430	-	
		SOT26		-	46	-	
		SOT363		-	143	-	
θ _{JC} Thermal Resistance Junction to-Case		X2-DFN0910-6	(Note 9)	-	255	-	°C/M
	to-Case	X2-DFN1010-6			250	-	
		X2-DFN1410-6		-	190	-	

Note: 9. Test condition for each of the 8 package types: Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

Operating Characteristics (@T_A = +25°C, unless otherwise noted.)

Р	arameter	Test Conditions	Vcc	ТҮР	Unit
C _{pd}	Power Dissipation Capacitance	f = 1MHz No Load	$0.8 V$ $1.2V \pm 0.1V$ $1.5V \pm 0.1V$ $1.8V \pm 0.15V$ $2.5V \pm 0.2V$ $3.3 \pm 0.3V$		pF
Cı	Input Capacitance	V _i = V _{CC} or GND	0 V or 3.3V	1.1	pF
Co	Output Capacitance	V ₀ = V _{CC} or GND	0 V	2.0	pF

Switching Characteristics

C _L =5pF, See	Figure 1										
Devenetar	From	то		1	r₄ = +25°C		T _A = -40°C	to +85°C	T _A = -40°C	to +125°C	Unit
Parameter	Input	OUTPUT	OUTPUT Vcc	Min	TYP	Max	Min	Max	Min	Мах	Unit
			0.8 V	-	28	-	-	-	-	-	
	А,		1.2 V ± 0.1 V	2.8	7.5	14.7	2.3	14.9	2.3	15.2	
t _{pd}	В,	Y	1.5 V ± 0.1 V	2.1	4.8	7.7	1.6	8.3	1.6	8.6	ns
чра	or		1.8 V ± 0.15 V	1.5	4	6.3	1	7	1	7.3	110
	С		2.5 V ± 0.2 V	1.1	3.2	4.6	0.6	5.2	0.6	5.4	
			3.3 V ± 0.3 V	1	2.9	4	0.5	4.2	0.5	4.4	



Switching Characteristics (continued)

C_L =10pF, See Figure 1

Parameter	From	то		r	Γ _A = +25°C		T _A = -40°C	to +85°C	T _A = -40°C 1	11	
Input	Input	put OUTPUT	V _{cc}	Min	TYP	Max	Min	Max	Min	Мах	Unit
			0.8 V	-	32	-	-	-	-	-	
	A,		1.2 V ± 0.1 V	3.2	8.4	16.5	2.7	17	2.7	17.3	
	В,	Y	1.5 V ± 0.1 V	2	5.4	8.8	1.5	9.5	1.5	9.8	n 0
t _{pd}	or	T	1.8 V ± 0.15 V	1.1	4.5	7.2	0.6	8	0.6	8.3	ns
	с		2.5 V ± 0.2 V	1	3.8	5.3	0.5	5.9	0.5	6.2	
			3.3 V ± 0.3 V	1	3.5	4.7	0.5	4.9	0.5	5.1	
C _L =15pF, Se	e Figure 1										

C_L=15pF, See Figure 1

Parameter	From	то	V	1	Γ _A = +25°C		T _A = -40°C	to +85°C	T _A = -40°C	to +125°C	Unit
Farameter	Input	ut OUTPUT	Vcc	Min	ТҮР	Мах	Min	Max	Min	Мах	Unit
			0.8 V	-	36	ł	-	-	<u> </u>	-	
	A,		1.2 V ± 0.1 V	3.6	9.5	18.4	3.3	19.8	3.3	20	
4	В,	Y	1.5 V ± 0.1 V	2.9	5.9	11.1	2.4	12	2.4	11	20
t _{pd}	or	T	1.8 V ± 0.15 V	2.2	5	9	1.7	9.9	1.7	9.2	ns
	С		2.5 V ± 0.2 V	1.7	4.2	6.7	1.2	7.5	1.2	6.9	
			3.3 V ± 0.3 V	1.4	3.9	5.9	0.9	6.3	0.9	5.8	
C _L =30pF, Se	CL=30pF, See Figure 1										

C_L=30pF, See Figure 1

Deveneter	From	rom TO		T _A = +25°C			T _A = -40°C	to 85°C	T _A = -40°C	Unit	
Parameter	Input	OUTPUT	Vcc	Min	ТҮР	Max	Min	Max	Min	Max	Unit
			0.8 V		46	-	-	-	-	-	
	А,		1.2 V ± 0.1 V	4.5	12	23.7	4.1	25	4.1	25.5	
t .	t _{pd} or Y		1.5 V ± 0.1 V	3.8	7.5	13.9	3.5	15.4	3.5	14.1	ns
ι _{pd}			1.8 V ± 0.15 V	3.2	6.3	11.4	2.7	12.8	2.7	11.9	115
	С		2.5 V ± 0.2 V	2.5	5.3	8.6	2	9.6	2	8.9	
			3.3 V ± 0.3 V	2.1	5	7.5	1.6	8.1	1.6	7.4	



Parameter Measurement Information

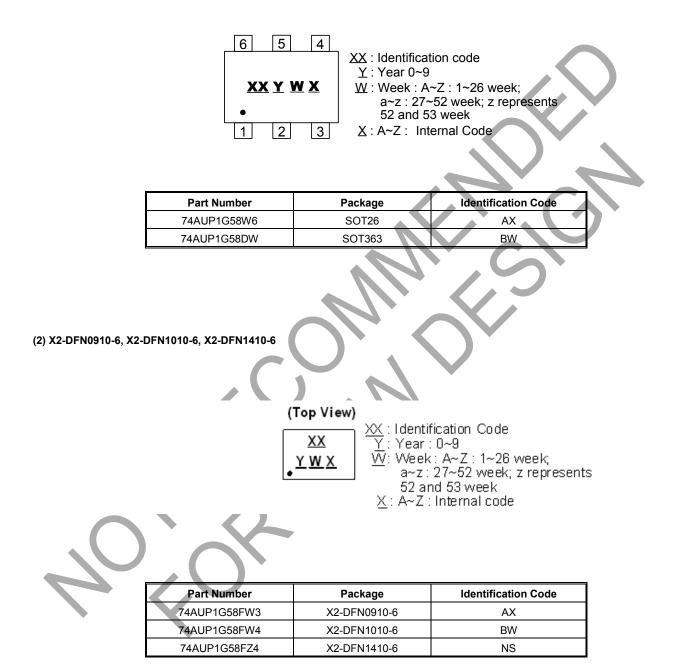
		m Output der Test C L – (see Note A)			
	Inputs		, v		
V _{cc}	VI	t _r /t _f	V _M	C∟	
0.8 V	Vcc	≤3ns	V _{cc} /2	5, 10, 15, 30 pF	
1.2V±0.1V	Vcc	≤3ns	Vcc/2	5, 10, 15, 30 pF	
1.5V±0.1V	V _{CC}	≤3ns	V _{cc} /2	5, 10, 15, 30 pF	
1.8V±0.15V	V _{CC}	≤3ns	V _{cc} /2	5, 10, 15, 30 pF	
2.5V±0.2V	V _{CC}	≤3ns	V _{CC} /2	5, 10, 15, 30 pF	
3.3V±0.3V	V _{CC}	≤3ns	V _{cc} /2	5, 10, 15, 30 pF	
Input Voltage Wavefo	orm Pulse Du	V _M 0 V ration			
~		\mathcal{A}	Output	VM VM ropagation Delay Times	
Inverting and Non Inverting Outputs Figure 1. Load Circuit and Voltage Waveforms Notes: A. Includes test lead and test apparatus capacitance.					
Notes: A. Includes test lead B. All pulses are sup	and test apparatu	is capacitance.	-		

- B. All pulses are supplied at pulse repetition rate \leq 10 MHz. C. Inputs are measured separately one transition per measurement. D. t_{PLH} and t_{PHL} are the same as t_{PD}.



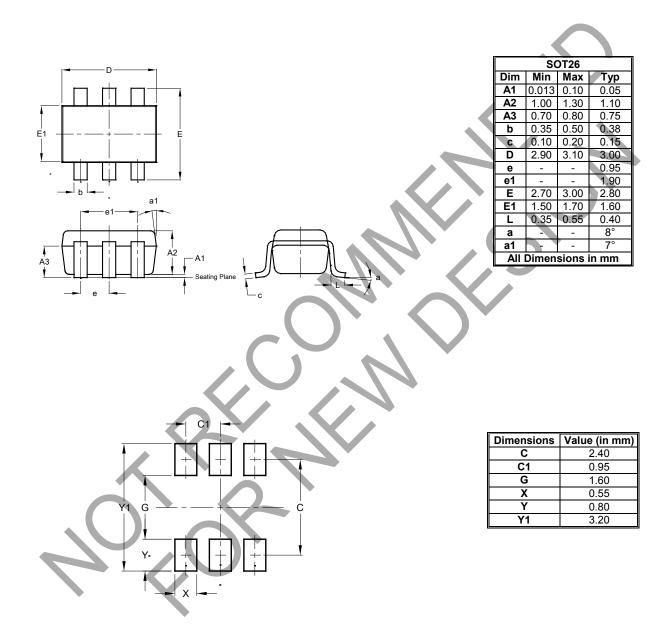
Marking Information

(1) SOT26, SOT363



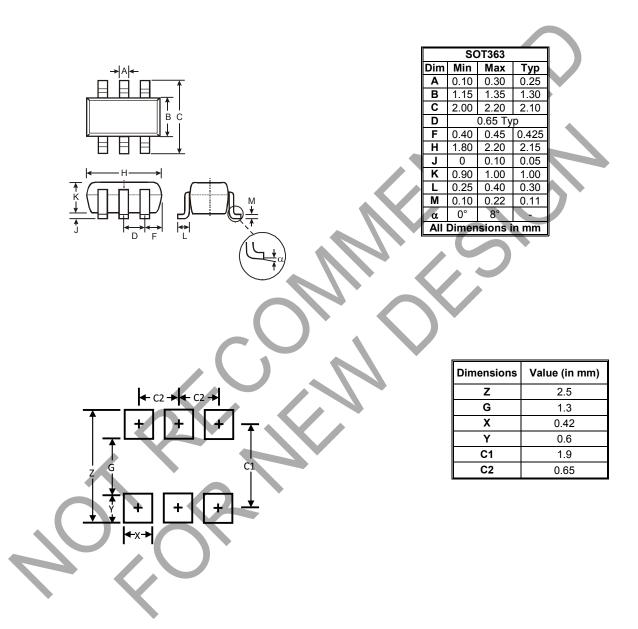


SOT26 Package Outline Dimensions and Suggested Pad Layout



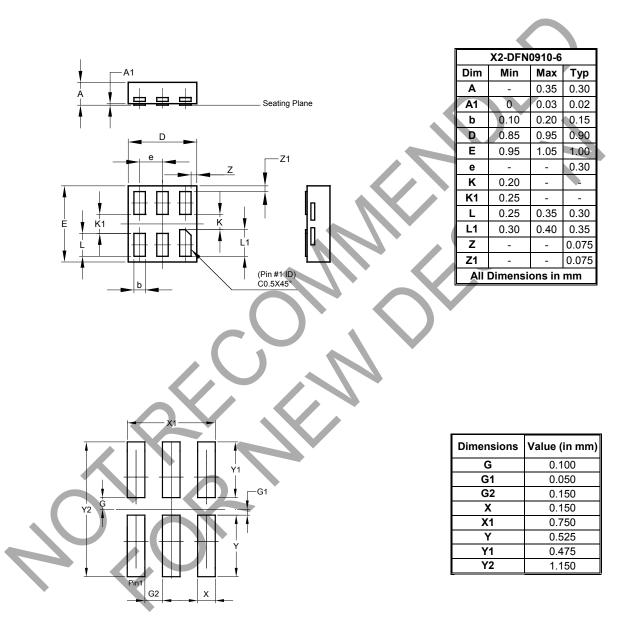


SOT363 Package Outline Dimensions and Suggested Pad Layout



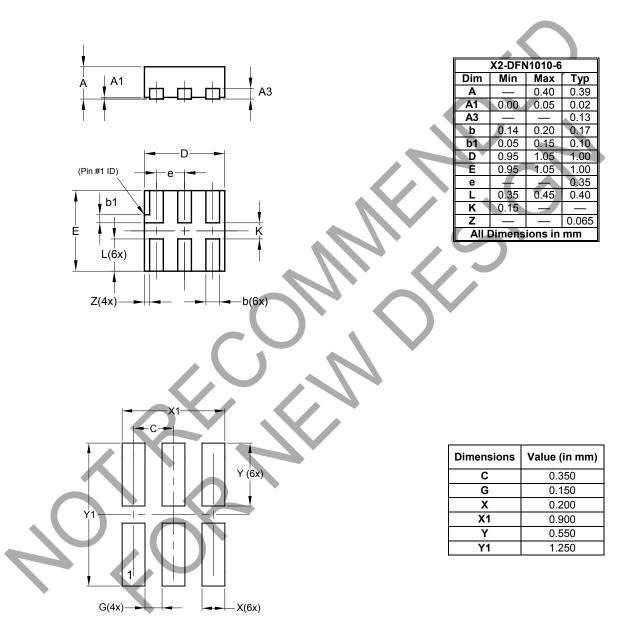


X2-DFN0910-6 Package Outline Dimensions and Suggested Pad Layout



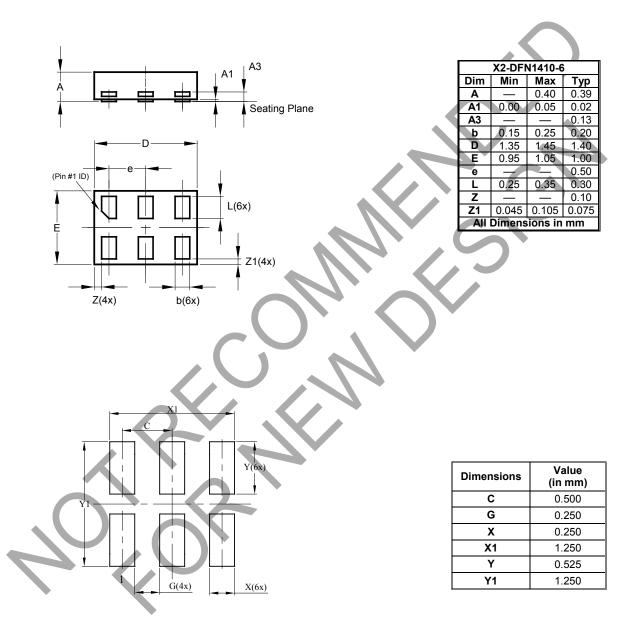


X2-DFN1010-6 Package Outline Dimensions and Suggested Pad Layout





X2-DFN1410-6 Package Outline Dimensions and Suggested Pad Layout





IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

A. Life support devices or systems are devices or systems which:

1. are intended to implant into the body, or

2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.

B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the

failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systemsrelated information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2019, Diodes Incorporated

www.diodes.com